

Search Notes

Application/Control No.

10/528,739

Examiner

Richard Chan

Applicant(s)/Patent under
Reexamination

SENESCHAL ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	71		
455	203		
455	46		
455	202		
455	265		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR